# SCHWEGMAN ■ LUNDBERG ■ WOESSNER ■ KLUTH

P.O. Box 2938 Minneapolis, MN 55402

Telephone (612) 373-6900

Facsimile (612) 339-3061

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February 7, 2001

Commissioner for Patents

Attn: George C. Eckert II

Patent Examining Corps

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Washington, D.C. 20231

FROM: Robert E. Males

OUR REF: 303.356US1

2841

**FAX NUMBER (703) 305-3431** 

TELEPHONE: (612) 373-6973

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\* Please deliver to Examiner George C. Eckert II in Art Unit 2815. \*

Document(s) Transmitted: Amendment and Response Under 37 CFR 1.116

(20 pgs)

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In rc. Patent Application of: Leonard Forbes et al.

Examiner: George C. Eckert II

Serial No.: 08/902,133

Group Art Unit: 2815

Filed: July 29, 1997

Docket No.: 303.356US1

DYNAMIC ELECTRICALLY ALTERABLE PROGRAMMABLE READ ONLY

MEMORY DEVICE

Please charge any additional fees or credit overpayment to Deposit Account No. 19-074

Name: Robert E. Mates

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### **EXPEDITED PROCEDURE - EXAMINING GROUP 2815**

## S/N 08/902,133

**PATENT** 

#### IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:

Lconard Forbes et al.

Examiner: George C. Eckert II

Serial No.:

08/902,133

Group Art Unit: 2815

Fil∞l:

July 29, 1997-

Docket: 303.356US1

Title:

DYNAMIC ELECTRICALLY ALTERABLE PROGRAMMABLE READ

ONLY MEMORY DEVICE

## AMENDMENT & RESPONSE UNDER 37 C.F.R. § 1.116

Box AF Commissioner for Patents Washington, D.C. 20231

In response to the final Office Action dated 20 September 2000, please amend the application as follows:

IN THE CLAIMS

Please cancel claims 1, 7, 11, 16, 33, and 38.

Please amend the claims as follows:

[Amended] The memory cell of claim [1] 22, wherein materials comprising at least one of the storage electrode and the insulator are selected to have an electron affinity causing the barrier energy to be selected at less than approximately 3.3 eV.

6. [Amended] The memory cell of claim [1] 22, wherein the insulator comprises a material that has a material composition that is selected to obtain a larger electron affinity than silicon dioxide.

[Amended] The memory cell of claim [1] 22, wherein the barrier energy is less than approximately 2.0 eV.

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